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Efficient inverted quasi-bilayer organic solar cells fabricated by using non-halogenated solvent processes†

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Here we demonstrate the fabrication of novel, "quasi-bilayer" inverted organic photovoltaic devices using halogen-free solvents. The inferior solubility of pristine fullerene in non-halogenated solvents was used to control the interpenetration of upper polymeric donor layers with bottom fullerene layers. Notably, islandlike nano-morphologies were revealed by AFM, SEM, TEM, cross-sectional TEM images and PL quenching measurement. Correlation between device performance, thin-film nano-morphology and ac impedance was observed. High efficiencies of 6.55% and 7.15% were observed for PBDTTT-C-T and PTB7 cells, respectively. These results demonstrate that this novel process not only offers an effective new method to control the morphology of solar active layers but, more importantly, could also be applied to a wide range of current material systems to produce efficient devices that comply with the non-toxic halogenfree requirement. PAPER

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1. Introduction

Organic solar cells (OSCs) have gained tremendous attention because of their unique properties, such as low-cost fabrication, low-energy consumption, roll-to-roll processing, semi-transparency and mechanical flexibility, which are required for a variety of applications.¹⁻⁸ OSCs fabricated with two fundamental architectures, bilayer configuration or bulk-heterojunction (BHJ), have demonstrated promising power conversion efficiencies (PCEs) of approximately $7-10\%$.⁹⁻¹⁶ In bilayer devices, the solar active layers are formed by sequential layer-by-layer deposition of donor and acceptor materials,¹⁷⁻²¹ whereas in BHJ devices, the active layer is formed by a single film composed of a mixture of donor and acceptor materials.²²⁻²⁴ It has recently been reported that solution-processed OSCs with a bilayer structure produced an interfacial BHJ layer between the neat donor and acceptor films, which provided a new method to control the degree of intermixing between the donor and acceptor.²⁵–³¹ In the aforementioned "quasi-bilayer" devices, [6,6]-phenyl-C₆₁-butyric acid methyl ester (PC₆₁BM) or [6,6]phenyl-C₇₁-butyric acid methyl ester (PC₇₁BM) was used as the

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electron accepting material. Because PCBM is highly soluble in common solvents, the device usually utilizes a bottom polymer layer with relatively poor solubility onto which an upper PCBM layer is sequentially solution-cast. A certain degree of interpenetration of PCBM into the polymer layer occurs, and a mixed donor-acceptor quasi-bilayer structure is formed.^{28,29}

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In these "quasi-bilayer" studies, and in most BHJ devices, halogenated aromatic solvents (e.g., chlorobenzene, dichlorobenzene, dichloromethane or chloroform) were selected for device preparation.³²⁻³⁶ Although the solubilities of polymers and fullerenes in halogenated aromatic solvents are typically significantly higher than those in halogen-free solvents, which makes device fabrication much easier, halogenated solvents are more toxic. This limits their potential mass use in environmentally friendly production. Therefore, the use of halogen-free solvents for the preparation of OSCs has been increasingly investigated.³⁷⁻³⁹ In this regard, A. K.-Y. Jen et al. have demonstrated the fabrication of an efficient BHJ solar cell with an impressively high PCE of up to 6–7% by utilizing a non-halogenated solvent mixture with 1-methylnaphthalene as an additive.^{40,41}

In this work, we report the fabrication of a highly efficient inverted quasi-bilayer OSC using non-halogenated solvent processes. The interpenetration of the upper donor layer and the bottom fullerene layer was well controlled by taking advantage of the reduced solubility of pristine fullerene in nonhalogenated solvents (solubility of C_{70} in toluene and o -xylene is \sim 1.4 mg ml⁻¹ and \sim 3.9 mg ml⁻¹, respectively). By using the rapid-drying blade-coating technique,^{42,43} "quasi-bilayer"

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structures were obtained in situ within a short period of time (less than one second) without any post-thermal or solvent annealing. Interpenetration was confirmed by atomic force microscopy (AFM), scanning electron microscopy (SEM), transmission electron microscopy (TEM) and cross-sectional TEM images.⁴⁴ Utilizing these quasi-layers, conceptual devices were fabricated and characterized based on the following smallbandgap polymers: poly[4,8-bis-(2-ethyl-hexyl-thiophene-5-yl) benzo[1,2-*b*:4,5-*b*']dithiophene-2,6-diyl]-*alt*-[2-(2′-ethyl-hexanoyl)thieno[3,4-b]thiophen-4,6-diyl] (PBDTTT-C-T)⁴⁵⁻⁴⁷ and thieno [3,4-b]thiophene/benzodithiophene (PTB7).⁴⁸–⁵² Under simulated 1-sun AM1.5 G illumination, high PCEs of 6.55% and 7.15% were observed for the PBDTTT-C-T and PTB7 cells, respectively. These results reveal that the process not only offers an effective way to control the morphology of active solar layers but also could be applied to a wide range of material systems for the production of efficient devices that comply with the nontoxic halogen-free requirement.

2. Experimental

2.1 Device fabrication

PBDTTT-C-T and PTBT were purchased and used as received from Solarmer Energy, Inc. and 1-Materials, respectively. Before use, C_{70} was subject to purification by temperature-gradient sublimation in a high vacuum chamber (pressure \sim 1 \times 10⁻⁶ Torr). Devices were fabricated with the structure of $ITO/Ca/C₇₀/$ PBDTTT-C-T or $PTB7/Moo₃/Ag$. ITO glass (sheet resistance: \sim 15 Ω sq⁻¹) was cleaned in an ultrasonic bath with de-ionized water, acetone, and methanol for 15 min, successively. A hole blocking cathode, Ca, and an acceptor layer, C_{70} , were deposited onto the ITO glass in a high vacuum chamber with a base pressure of \sim 1 \times 10⁻⁶ Torr. The polymers were dissolved in toluene (9 mg ml $^{-1}$) and *o-*xylene (9 mg ml $^{-1}$). The co-solvent process was performed by mixing the o-xylene solution with the toluene solution at varying proportions ranging from 0 to 20 wt%. The polymer solution was then cast onto the bottom C_{70} layer by the fast-drying blade-coating method with the blade speed ranging from 60 to 350 mm s^{-1} (controlled by a servomotor). The blade-coating process was performed on a hot plate at 90 degree Celsius, and the polymer film dried in ≤ 1 s (see Table S1 \dagger). The films remained on the hot plate for \sim 5 minutes to completely evaporate the solvents. All processes were performed inside a glove box filled with nitrogen. After casting the polymer donor layer, the samples were transferred to a vacuum chamber for deposition of the $MoO₃$ hole extraction layer and metal electrode. A conventional BHJ cell with a blade-coated active layer and the following device structure ITO/Ca/PBDTTT-C-T:C₇₀ (1:1.5, 15 mg cm⁻³)/MoO₃/Ag was fabricated using o-DCB as the solvent. After fabrication, the devices were encapsulated with a UV-cured sealant (Everwide Chemical Co. Epowide EX) and cover glass under anhydrous nitrogen and measured in air. The average size of the active cell area was 5 mm². The deviation values were obtained from device-todevice variations of 4–8 devices. The thin films for TEM brightfield top-view investigation were prepared by immersing the glass/PEDOT:PSS/C70/PBDTTT-C-T samples into deionized

water. After dissolution of PEDOT:PSS, the C_{70} /PBDTTT-C-T films floated onto the water surface and were transferred to a TEM grid.⁵³ Optical constants $(n,$ refractive index and $k,$ extinction coefficient) of PBDTTT-C-T, C_{70} and MoO₃ (Fig. S2 \dagger) were obtained by spectroscopic ellipsometry with the following procedure: the thickness of the thin film was first determined by assuming *n* in the transparent region ($k = 0$ at 850–1100 nm) to obey the Cauchy equation in tting the ellipsometric values in the corresponding region. With the determined thickness, n and k were then varied independently across the whole spectral range of interest to fit the ellipsometric values at each wavelength (point-by-point fitting).⁵⁴

2.2 Characteristic measurements

Current density–voltage characteristics were measured with a Source Meter Keithley 2400 under AM1.5 G solar illumination from a xenon lamp solar simulator (Abet Technologies) operating at 100 mW cm^{-2} (calibrated with a NREL-traceable DG5 filtered silicon reference cell). The series resistance (R_S) and shunt resistance (R_{SH}) are estimated from the inverse slopes of the $J-V$ curves at the open-circuit and short-circuit points, respectively. The external quantum efficiency spectra were obtained by illuminating periodically modulated monochromatic light with continuous-wave bias white light (from halogen lamp) on the solar cells. The photocurrent signals were extracted using a lock-in technique that used a current preamplifier (Stanford Research Systems) followed by a lock-in amplifier (AMETEK). The EQE measurement was entirely computer controlled, and the monochromatic light intensity was calibrated with an NIST-traceable optical power meter (Ophir Optronics) (chopper frequency ~ 85 Hz). Absorption spectra were acquired with a U-3900 Spectrophotometer (Hitachi). Optical constants (refractive index, n , and extinction coefficient, k) and film thicknesses were measured using a J. A. Woollam Inc. V-VASE variable-angle spectroscopic ellipsometer. Atomic force microscopy (AFM) images were analyzed with a Bruker Dimension Icon® Atomic Force Microscope operating in tapping mode. Scanning electron microscopy (SEM) images were taken with a HitachiSU8010 microscope. A home-built panchromatic optical field simulation program, coded in Matlab™ and based on the transfer matrix method, was utilized to model optical field distributions and exciton formation.⁵⁵⁻⁵⁷ Transmission electron microscopy images were analyzed with a JEOL JEM-1200x transmission electron microscope (accelerating voltage: 120 keV). The photoluminescence emission was detected in a front-face configuration using a fiber based spectrograph and a He–Cd laser ($\lambda = 325$ nm) as the pumping source. **Paper**
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3. Results and discussion

3.1 Devices with toluene as solvent and optical simulation

Fig. 1 shows the molecular structures of the active materials used in this study. A schematic diagram of an inverted solar cell structure with either ITO/Ca $(1 \text{ nm})/\text{C}_{70}$ $(50 \text{ nm})/\text{PBDTTT}$ -C-T or PTB7/MoO₃ (7 nm) /Ag (110 nm) is also shown in Fig. 1.

Fig. 1 Device schematic and chemical structures of PBDTTT-C-T, PTB7 and C₇₀

To verify the concept, PBDTTT-C-T was first used as the donor. The PBDTTT-C-T layer was deposited onto a vacuumsublimed C_{70} bottom layer by blade-coating with a blade speed ranging from 60 to 350 mm $\rm s^{-1}.$ The blade speed dependent PBDTTT-C-T thickness is shown in Fig. S1.† Utilizing toluene as the solvent for PBDTTT-C-T enabled the fabrication of a "bilayer" device with a small intermixing zone because C_{70} has a low solubility in toluene (1.4 mg ml^{-1}). Fig. 2a shows the short circuit current $(J_{\rm sc})$ and power conversion efficiency (PCE) of toluene-cast devices. The simulated PCE values were obtained from a home-made optical field calculation program with assumption of 10 nm exciton diffusion length in both polymer and fullerene and experimentally acquired $V_{\text{oc}} \sim 0.72$ and FF \sim 0.65.⁵⁸ The optimal device had a PBDTTT-C-T thickness of \sim 40 nm.

Devices with thicker or thinner PBDTTT-C-T layers demonstrated inferior performance. It is hypothesized that the short exciton diffusion length (L_{ex}) of organic semiconductors (~10 nm) plays a critical role in these results.⁵⁸ Placing the donor/ acceptor interface of the bilayer device at the resonant peak of the optical field was necessary to optimize the light harvesting efficiency. Fig. 2b shows the calculated optical field distribution of devices with various PBDTTT-C-T thicknesses. It indicates that a PBDTTT-C-T thickness of \sim 40 nm and a MoO₃ optical spacer of 7 nm enhanced the optical field strength near the donor/acceptor interface, which explains the high value for $J_{\rm sc}$ that was observed for the 40 nm PBDTTT-C-T cell. Additionally, a maximum $J_{\rm sc}$ value of 11.0 mA cm⁻² and a PCE of up to 5.08% were obtained (device characteristics are summarized in Fig. S3, S4 and Table S2†).

3.2 Fabrication and morphological characteristics of cosolvent (toluene : o-xylene) cells and conventional BHJ devices

Manipulating the degree of intermixing near the donor/ acceptor interface had the following 2 advantages: (1) improved exciton dissociation efficiency by increasing the surface area of the donor/acceptor junction and (2) the in situ formation of a

Fig. 2 (a) Measured $J_{\rm sc}$ (black squares), PCE (red circle) and simulated PCE (red line) of C₇₀/PBDTTT-C-T devices with varying PBDTTT-C-T layer thicknesses and (b) optical field distributions of devices with varying PBDTTT-C-T layer thicknesses at the maximum absorption wavelength of 500 nm. The gray line represents the donor/acceptor interface. Device structure: ITO/Ca (1 nm)/C₇₀ (50 nm)/PBDTTT-C-T/ $MO_{\frac{7}{2}}$ (7 nm)/Ag (110 nm).

favorable vertical phase separation for smooth carrier transport. Compared to toluene, C_{70} is slightly more soluble in the nonhalogenated solvent o-xylene. By controlling the co-solvent ratio (toluene : o-xylene) of the upper polymer solution, the intermixing of the polymer and bottom C_{70} layer was continuously tuned. Both the "quasi-bilayer" devices, fabricated with varying proportions of o-xylene that ranged from 0 to 20 wt% and conventional BHJ reference cells were characterized. The device parameters, R_S and R_{SH} , are summarized in Fig. 3 and Table 1. The optimal cell, which was produced with toluene : o -xylene $=$ 95 : 5, wt%, had the highest PCE of 5.84%, an open circuit voltage (V_{oc}) = 0.70 V, J_{sc} = 12.3 mA cm⁻², and FF = 0.68. Compared to the cell fabricated using pure toluene (PCE $=$ 5.08%, $V_{\text{oc}} = 0.72 \text{ V}, J_{\text{sc}} = 11.0 \text{ mA cm}^{-2}$, and FF $= 0.64$), adding o -xylene during production mainly increased the device J_{sc} . This is attributed to the increased donor/acceptor interface that occurred by intermixing the donor and acceptor layers. Interestingly, the cells (toluene : o -xylene = $100 : 0-90 : 10$, wt%) all exhibited a similar R_S and R_{SH} , which may indicate good phase separation and the reduction of charge recombination in the intermixing region.⁵⁹ Moreover, a comparable or slightly higher FF was observed in cells that were processed with 1–10 wt% cosolvent. This indicates that a certain vertical phase separation

Fig. 3 (a) J–V characteristics under 1 sun simulated AM1.5 G illumination and (b) the EQE spectra of the conventional bulk heterojunction (C-BHJ) device and quasi-bilayer devices fabricated using various cosolvent ratios (toluene : o-xylene, wt%). Quasi-bilayer device structure: ITO/Ca (1 nm)/C₇₀ (50 nm)/PBDTTT-C-T (40 nm)/MoO₃ (7 nm)/ Ag (110 nm).

was maintained, as was observed in the bilayer case, and that the carriers were able to travel easily to the electrodes. However, with the addition of too much *o*-xylene (20 wt%), the advantageous vertical phase separation began to dissipate, and the devices had lower $J_{\rm sc}$, FF and PCE values. The extreme case of complete mixing of C_{70} and PBDTTT-C-T was represented by a BHJ reference cell. Unlike the quasi-bilayer devices, the BHJ device fabricated using o-DCB as a solvent showed poor performance, which can be attributed to undesirable bulk and vertical phase separation.

From the EQE results shown in Fig. 3b, the optimal (toluene : o -xylene = 95 : 5, wt%) device showed enhanced light harvesting efficiency over the wavelength range from 350 nm to 850 nm, compared to the toluene : o -xylene = 100 : 0, wt% device. To clarify whether the apparent higher current density and EQE of the toluene : o -xylene = 95 : 5, wt% device were caused by increased photon absorption or a higher exciton dissociation efficiency, UV-Vis spectroscopy was performed on the C_{70} neat film, the PBDTTT-C-T neat film, and the C_{70} / PBDTTT-C-T thin films coated on fused silica substrates. The preparation conditions were kept the same as for the device fabrication.

As indicated in Fig. 4, the absorption spectra of the C_{70} / PBDTTT-C-T thin films displayed the approximate combinatorial absorption of the C_{70} and PBDTTT-C-T neat films. This demonstrates that the donor was successfully deposited on top of the C_{70} layer by the rapid-drying blade-coating technique. In addition, the toluene : o -xylene = 95 : 5, wt% and toluene : o xylene $= 80 : 20$, wt% films had a lower absorbance than the toluene : o -xylene = 100 : 0, wt% device, which was observed at 450–600 nm. This can be attributed to the slight decrease in thickness of the C_{70} layer, which was possibly eliminated by the o-xylene solvent. The UV-Vis absorption results clearly indicate that the amount of photon absorption in the toluene : o-xylene $= 95 : 5$, wt% cell was almost identical or even slightly lower than in the toluene : o -xylene = 100 : 0, wt% device.

Fig. 4 Absorption spectra of the 40 nm PBDTTT-C-T neat film, 50 nm C_{70} neat film, and C_{70} (50 nm)/PBDTTT-C-T (40 nm); the PBDTTT-C-T layers were prepared by toluene : o -xylene = 100 : 0, wt%, toluene : o-xylene $= 95 : 5$, wt% and toluene : o-xylene $= 80 : 20$, wt% solutions.

Thus, the higher $J_{\rm sc}$ and EQE of the toluene : o-xylene = 95 : 5, wt% device can only be attributed to a higher exciton dissociation efficiency, which is because of a larger donor/ acceptor interface. Furthermore, by comparison of the PBDTTT-C-T neat film and C_{70} /PBDTTT-C-T thin-film photoluminescence (PL) emission at 820 nm (the emission of PBDTTT-C-T),⁶⁰ one observed a greater PL quenching in $C_{70}/$ PBDTTT-C-T films prepared using higher *o*-xylene ratios (91.9%) (toluene : o -xylene = 100 : 0, wt%) vs. 97.1% (toluene : o -xylene $= 80 : 20$, wt%)), indicating more efficient charge transfer and intermixing between PBDTTT-C-T and C_{70} (Fig. 5).⁶¹

To gain more insight into the correlation between device performance and nano-morphology of the PBDTTT-C-T/C₇₀ mixture, atomic force microscopy (AFM), transmission electron microscopy (TEM) and cross-sectional TEM measurements were performed. Since AFM topography only probes the surface features of the film, the structure of the intermixing layer was later examined in TEM results, which provided more detailed information on the interior of the quasi-bilayer thin films. Fig. 6 shows the surface morphology of the neat C_{70} film and $C_{70}/$ PBDTTT-C-T thin films, respectively. The C_{70} neat film, which was deposited by vacuum evaporation, displayed an extremely smooth surface with a root-mean-square roughness $(R_{\rm rms})$ of 0.89 nm, as shown in Fig. 6a. After blade coating the donor on top of the C_{70} layer with a pure toluene solution, the film (Fig. 6b) presented hill-like structures with a high $R_{\rm rms}$ of 5.95 nm. Moreover, the surface morphology of the toluene : o-xylene $= 95 : 5$, wt% and toluene : o-xylene $= 80 : 20$, wt% thin films showed even greater surface roughness with $R_{\rm rms}$ values of 16.2 nm and 20.1 nm, respectively (AFM characteristics are listed in Table S3†). The AFM image and roughness parameter of the pure polymer thin-film are shown in Fig. S7b and Table S3,[†] respectively. The film showed a smooth surface with an $R_{\rm rms}$ of 0.81 nm. The results suggest that the hill-like structures were originated from partially dissolved C_{70} under-layers. **Publish Chemisty A** Wave Reading China at the solution of a later domestic on 2014. The main control of a later of the control of a later of the control of a later of the chiao Tung University on 2014. The main control o

The changes in nano-morphology of the $C_{70}/PBDTTTC-T$ quasi-bilayer using various proportions of the o-xylene co-

Fig. 5 The front-face PL of the PBDTTT-C-T (40 nm) neat film and C_{70} (50 nm)/PBDTTT-C-T (40 nm) thin films; the PBDTTT-C-T layers were prepared by toluene : o-xylene $= 100$: 0, wt%, toluene : o-xylene $=$ 95 : 5, wt% and toluene : o -xylene = 80 : 20, wt% solutions. The PL data are normalized to the amount of PBDTTT-C-T thin-film absorption.

Fig. 6 AFM images of the (a) C_{70} (50 nm) neat film, (b) C_{70} (50 nm)/ PBDTTT-C-T (40 nm) (toluene : o -xylene = 100 : 0, wt%) thin film, (c) C_{70} (50 nm)/PBDTTT-C-T (40 nm) (toluene : o-xylene = 95 : 5, wt%) thin film, and (d) C_{70} (50 nm)/PBDTTT-C-T (40 nm) (toluene : o-xylene $= 80 : 20$, wt%) thin film.

solvent were more apparent in bright-field TEM images, as shown in Fig. 7 (focused) and S5† (defocused). Notably, the TEM images reveal randomly oriented, island-like nano-structures. The density and contrast of these island-like nano-structures increased with o-xylene wt%, which is consistent with the AFM result. The variation in image contrast could result from different compositions or thin-film thicknesses. The electron density of fullerenes has been observed to be higher than that of polymers.28,40,62–⁶⁵ As a result, the higher mass-thickness contrast of C_{70} gives the dark C_{70} -rich domains from the bright region of the PBDTTT-C-T-rich matrix. TEM images show the island-like nano-structures which are consistent with the SEM image (inset of Fig. 7b). In contrast, the SEM image of the (toluene : o -xylene = $95 : 5$, wt%) PBDTTT-C-T neat film showed a smooth surface (Fig. S7a†). Accordingly, the island-like nanostructures could represent a certain degree of C_{70} aggregation, which is likely attributed to the selective solubility of C_{70} and PBDTTT-C-T in toluene and o -xylene. The toluene : o -xylene = 95 : 5, wt% and toluene : o -xylene = $80:20$, wt% films showed a higher density of island-like nano-structures compared to the toluene : o -xylene = 100 : 0, wt% one, which could be beneficial to the larger donor/acceptor interface.

To acquire more information on the nano-morphology of the device, cross-sectional TEM images obtained by two different slicing methods were investigated (detail processes are shown in Fig. S7†). Fig. 8 and S7a† show the cross-sectional TEM images with the following structure: ITO/PEDOT:PSS (40 nm)/ C_{70} (60 nm)/PBDTTT-C-T (toluene : o -xylene = 95 : 5, wt%)/Al at different magnifications. The wavy interface of the donor and acceptor layers can be resolved, indicating that the donor and acceptor layers were not well-mixed in the process. The images also display a vertical contrast in the active layer. The brighter upper region is distinguished from the darker lower region, implying that the active layer gradually changes from C_{70} -rich to a PBDTTT-C-T-rich matrix from the bottom to the top and the formation of a diffusive quasi-bilayer structure. Referring to the

Fig. 7 TEM micrographs of C_{70} (50 nm)/PBDTTT-C-T (40 nm) thin films; the PBDTTT-C-T layers were prepared by (a) toluene : o-xylene = $100 : 0$, wt%, (b) toluene : o-xylene = 95 : 5, wt%, and (c) toluene : o-xylene = 80 : 20, wt% solutions. The inset of (b) shows the 45 degree of the SEM image with the same conditions as (b).

Fig. 8 Cross-sectional TEM image $(30 000 \times)$ of ITO/PEDOT:PSS (40 nm)/C₇₀ (60 nm)/PBDTTT-C-T (toluene : o-xylene = 95 : 5, wt%) $(40 \text{ nm})/$ Al

AFM, TEM and SEM results, an illustration of the quasi-bilayer with island-like nano-structures is shown in Fig. 9. By selecting non-halogenated solvents with two different C_{70} solubilities and using the rapid-drying blade-coating method, we fabricated a controllable inter-diffusive quasi-bilayer that increased device performance. The increased surface roughness and a large mixture layer observed in the toluene : o -xylene = $80 : 20$, wt% thin film may have caused direct contact of PBDTTT-C-T with the cathode and/or C_{70} with the anode which could lead to leakage current and lower device performance.

3.3 Devices with optimized C_{70} and MoO₃ thickness

Because there was a thicker intermixing layer in devices fabricated with a (toluene : o -xylene = 95 : 5, wt%) co-solvent, the optimal thickness of C_{70} for these devices may not be the same thickness that was determined for toluene-fabricated cells.

Fig. 9 Illustration of the thin-film morphologies of a (a) conventional bilayer, (b) C_{70} /PBDTTT-C-T film (toluene : o-xylene = 100 : 0, wt%), (c) C_{70} /PBDTTT-C-T film (toluene : o-xylene = 95 : 5, wt%) and (d) C_{70} /PBDTTT-C-T film (toluene : o-xylene = 80 : 20, wt%).

Therefore, the thickness of C_{70} was first optimized for the purpose of maximizing the optical field distribution in the active layer. The device parameters are summarized in Table 2 and the J–V characteristics are shown in Fig. 10 and 11. As shown in the inset of Fig. 10, the optimal device (60 nm C_{70}) showed an increased EQE value of up to \sim 70% within the wavelength range of 400–550 nm, which corresponds to C_{70} absorption. The device possessed a $V_{\text{oc}} = 0.72 \text{ V}$, $J_{\text{sc}} =$ 13.3 mA cm^{-2} , FF = 0.67, and delivered a PCE of up to 6.46%.

The AFM and TEM results suggest that $7 \text{ nm } \text{MoO}_3 \text{ may not}$ fully cover the active quasi-bilayer with high surface roughness. We then fine-tuned the thickness of $MoO₃$ to further optimize device performance. As shown in Fig. 11, the device with 3 nm $MoO₃$ performed the poorest among all the cells. This is because low coverage of the MoO₃ layer caused direct contact of the active layer with the exciton quenching metal electrode.⁶⁶ Increasing the $MoO₃$ thickness significantly improved the device performance. However, efficiency decreased in devices with >10 nm MoO₃, which can be attributed to the effect of optical resonance inside the active layer. As a result, the optimal device with a 10 nm layer of $MoO₃$ gave an impressive performance with $V_{\text{oc}} = 0.71 \text{ V}, J_{\text{sc}} = 13.6 \text{ mA cm}^{-2}, \text{ FF} = 0.68, \text{ and a}$ PCE as high as 6.55%.

For comparison, ZnO and CsF were also utilized as electron extraction layers in this study. However, they all demonstrated lower PCEs in the range of 2.17–4.27% (see Fig. S8–11 and Tables S4 and S5†). This could have been caused by increased charge recombination or higher surface roughness of the ZnO and CsF layers. A detailed mechanism is still under investigation.

3.4 Devices with a PTB7 donor layer

To demonstrate that the approach proposed in this study can be widely adopted in various polymer systems, we used PTB7 as the donor layer in a quasi-bilayer device. The fabrication process and the device structure were the same as for the optimized PBDTTT-C-T devices: ITO/Ca $(1 \text{ nm})/C_{70}$ $(60 \text{ nm})/PTB7$ $(20-$ 100 nm, toluene : o -xylene = 95 : 5, wt%)/MoO₃ (10 nm)/Ag (110 nm) . The $I-V$ characteristics and EQE spectra of these devices are shown in Fig. 12 and S12–S14 and Tables S6 and S7.† Tuning the thickness of the PTB7 layer showed a trade-off

Table 2 Performance parameters of devices with various C_{70} and MoO₃ layer thicknesses

Fig. 10 $J-V$ characteristics of devices with various C₇₀ layer thicknesses. The inset shows the corresponding EQE spectra. Device structure: ITO/Ca (1 nm)/C₇₀/PBDTTT-C-T (40 nm)/MoO₃ (7 nm)/Ag (110 nm).

Fig. 11 $J-V$ characteristics of devices with various MoO₃ layer thicknesses. The inset shows the corresponding EQE spectra. Device structure: ITO/Ca (1 nm)/C₇₀ (60 nm)/PBDTTT-C-T (40 nm)/MoO₃/Aq (110 nm).

between $J_{\rm sc}$ and FF. The optimal thickness of PTB7 was determined to be 70 nm, which delivered a PCE of up to 7.01% \pm 0.14% [max 7.15%], $V_{\text{oc}} = 0.69 \pm 0.01$ V [max 0.70 V], $J_{\text{sc}} = 13.9 \pm 0.01$ 0.2 mA cm⁻² [max 14.1 mA cm⁻²], and FF = 72.1 \pm 0.09% [max 73.0%]. This efficiency is comparable to PTB7BHJ solar cells fabricated using halogenated solvents and additives.⁵⁰

Fig. 12 J-V characteristics of devices with a 70 nm PTB7 layer. The inset shows the corresponding EQE spectrum. Device structure: ITO/ Ca (1 nm)/C₇₀ (60 nm)/PTB7 (70 nm)/MoO₃ (10 nm)/Ag (110 nm).

Intensity dependent device performance of the optimal PTB7 quasi-bilayer solar cell is shown in Fig. S13† in the ESI.† The device demonstrated higher efficiency under low illumination. The PCE reached a maximum of $\sim8\%$ at a simulated light intensity of ~ 0.08 sun.

4. Conclusions

In summary, we have conceptually demonstrated the fabrication of inverted quasi-bilayer OSCs by utilizing poorly soluble vacuum-deposited C_{70} and non-halogenated solvent deposited polymers. The interfacial interpenetration mixture was continuously controlled by tuning the compositional ratio of the toluene : o-xylene co-solvent. The correlation between device performance and thin-film nano-morphology was comprehensively studied using AFM, TEM, SEM, cross-sectional TEM and PL quenching measurement. An unusual island-like morphology was observed. After engineering the donor/ acceptor interface and optimizing device optics and morphology, PBDTTT-C-T and PTB7 cells demonstrated high PCEs of up to 6.55% and 7.15% under simulated 1-sun illumination, respectively. The PTB7 device showed a higher PCE of \sim 8% at low illumination intensity (0.08 sun). These efficiencies are comparable to state-of-the-art BHJ devices fabricated using halogenated solvents. The cells developed in this study have the

following three advantages over traditional BHJ devices: (1) the enhanced control over the BHJ offered by quasi-bilayer processing when compared to blend casting; (2) the mixture of the bottom C_{70} layer and the upper polymer layer occurred within 1 second without long-time solvent or thermal annealing; and (3) the halogenated-solvent-free fabrication conforms to the halogen-free compliance. Our results provide important insight into novel device structures and fabrication processes, which may trigger advanced efforts in the production of non-toxic, fast-throughput, and large-area OSCs. **Paper**
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